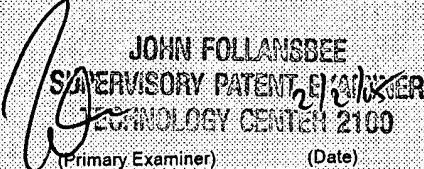


<b>Issue Classification</b> 	Application No.	Applicant(s)
	09/652,735	AUNE, LEIF EINAR
	Examiner	Art Unit
	Philip C Lee	2154

## ISSUE CLASSIFICATION

ORIGINAL				CROSS REFERENCE(S)						
CLASS		SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
709		228	709	228	222	245				
INTERNATIONAL CLASSIFICATION				370	401	313	338			
G	0	6	F	15/177						
G	0	6	F	15/16						
H	0	4	L	12/28						
H	0	4	Q	7/00						
H	0	4	Q	7/24						
 (Assistant Examiner) (Date)				 <b>JOHN FOLLANSBEE</b> SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2100 (Primary Examiner) (Date)				Total Claims Allowed: 7  O.G. Print Claim(s)      1  O.G. Print Fig.      2		

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
1		31		61		91	
2		32		62		92	
3		33		63		93	
4		34		64		94	
5		35		65		95	
6		36		66		96	
7		37		67		97	
8		38		68		98	
9		39		69		99	
10		40		70		100	
11		41		71		101	
12		42		72		102	
13		43		73		103	
14		44		74		104	
15		45		75		105	
16		46		76		106	
17		47		77		107	
18		48		78		108	
19		49		79		109	
20		50		80		110	
21		51		81		111	
22		52		82		112	
23		53		83		113	
24		54		84		114	
25		55		85		115	
26		56		86		116	
27		57		87		117	
28		58		88		118	
29		59		89		119	
30		60		90		120	